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Supporting Information (SI)

## Tailoring the Thermoelectric and Structural Properties of Cu-Sn Based Thiospinel Compounds [ $CuM_{1+x}Sn_{1-x}S_4$ (M = Ti, V, Cr, Co)]

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*Figure S1*. *Rietveld refinement for the (a)*  $CuCrSnS_4$ , and (b)  $CuCr_{1.1}Sn_{0.9}S_4$  thiospinel compounds.



*Figure S2*. *Rietveld refinement for the*  $CuCo_{0.5}Sn_{1.5}S_4$  *thiospinel compound.* 



*Figure S3*. Rietveld refinement for the (a)  $CuTiSnS_4$ , and (b)  $CuTi_{1.1}Sn_{0.9}S_4$  thiospinel compounds.

**Table S1.** Atomic coordinates and atomic occupancy of the obtained from Rietveld refinement X-ray powder diffraction patterns ( $\lambda_{Cu} = 1.5418 \text{ Å}$ ) of the  $Cu(M;Sn)_2S_4$  (M = Co, Ti and Cr) sample after Spark Plasma Sintering at room temperature \*These values have been fixed due to too close Z values of metallic atoms and due to the resolution limit of the XRD Rietveld analysis.

	*Occ. (Cu)	*Biso (Cu)	Occ. <sub>exp</sub> (M)	Occ. <sub>theo</sub> (M)	Occ <sub>exp</sub> (Sn)	Occ <sub>theo</sub> (Sn)	*Biso (M/Sn)	*Occ . (S)	x position (S)	*Biso (S)
CuCo <sub>0.5</sub> Sn <sub>1.5</sub> S <sub>4</sub>	1	0.5	0.17	0.25	0.83	0.75	0.5	_ 1	0.2548	0.5
$CuTi_{0.9}Sn_{1.1}S_4$	1	0.5	0.4	0.45	0.6	0.55	0.5	1	0.2404	0.5
CuTiSnS₄	1	0.5	0.51	0.5	0.49	0.5	0.5	1	0.2441	0.5
CuTi <sub>1.1</sub> Sn <sub>0.9</sub> S <sub>4</sub>	1	0.5	0.53	0.55	0.47	0.45	0.5	1	0.2418	0.5
CuCrSnS <sub>4</sub>	1	0.5	0.52	0.5	0.48	0.5	0.5	1	0.2464	0.5
CuCr <sub>1.1</sub> Sn <sub>0.9</sub> S <sub>4</sub>	1	0.5	0.57	0.55	0.43	0.45	0.5	1	0.2457	0.5
$CuCr_{1.2}Sn_{0.8}S_4$	1	0.5	0.61	0.6	0.39	0.4	0.5	1	0.2454	0.5

**Table S2**. Computed carrier concentration and effective mass values at room temperature for  $CuM_{1+x}Sn_{1-x}S_4$  (x=0 for M=Ti, Cr, and x=-0.5 for M=Co)<sup>a</sup> with  $\lambda = 0.5$ .

Computed transport properties (based on band structures)	CuCo <sub>0.5</sub> Sn <sub>1.5</sub> S <sub>4</sub>	CuTiSnS <sub>4</sub>	CuCrSnS <sub>4</sub>
Carrier concentration, $n$ (cm <sup>-3</sup> )	1.6 x 10 <sup>20</sup>	1.9 x 10 <sup>20</sup>	3.3 x 10 <sup>19</sup>
Effective mass, $m^*$ ( $m_e$ )	2.17	0.33	3.36



*Figure S4.*  $CuV_{1+x}Sn_{1-x}S_4$  series – (a) XRD patterns, (b) electrical and thermal transport properties at room temperature.

**Table S3**. Specific Sn-S and M-S distances (Å, M = Co, Ti, Cr, V) of  $CuM_{1+x}Sn_{1-x}S_4$  (x = 0 for M = Ti, V, Cr, and x = -0.5 for M = Co) this pinel compounds.

Structural Information	CuCo <sub>0.5</sub> Sn <sub>1.5</sub> S <sub>4</sub>	CuTiSnS <sub>4</sub>	CuCrSnS <sub>4</sub>	CuVSnS <sub>4</sub>
	2.583 (a)	2.534 (a)	2.517 (a)	2.535 (a)
Sn S	2.628 (b)	2.555 (b)	2.560 (b)	2.548 (b)
511-5	2.660 (c)	2.578 (c)	2.567 (c)	2.558 (c)
	2.662 (d)	2.609 (d)	2.594 (d)	2.590 (d)
		2.511 (a)	2.440 (a)	2.465 (a)
M-S	2.466 (a, b, d)	2.520 (b)	2.484 (b)	2.480 (b)
(M = Co, Ti, Cr, V)	2.623 (b, d, c)	2.575 (c)	2.495 (c)	2.519 (c)
		2.601 (d)	2.567 (d)	2.537 (d)

Note: Please refer Figure S5 for a, b, c, and d labeling in Table S3.



*Figure S5.* Distorted octahedral environment of M (M = Co, Ti, Cr, V) and Sn of  $CuM_{1+x}Sn_{1-x}S_4$  (x = 0 for M = Ti, V, Cr, and x = -0.5 for M = Co) thiospinel compounds.



*Figure S6*. Spin-polarized density of states (DOS) of (a)  $CuCo_{0.75}Sn_{1.25}S_4$ , and (c)  $CuCoSnS_4$  hypothetical models.